

**Search Notes**

Application/Control No.

10/071,174

Examiner

J. Eric Angell

Applicant(s)/Patent under  
Reexamination

REED ET AL.

Art Unit

1635

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN, EAST, Inventor Name search STIC seq search, reviewed/updated	12/5/2007	JEA